

Notice of References Cited

Application/Control No.

10/591,340

Applicant(s)/Patent Under
Reexamination
ROSSEN ET AL.

Examiner

SUN JAE Y. LOEWE

Art Unit

1626

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U.S. PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Dormoy et al., Synthesis, 1986, pg. 81-82
	V	Hacks Chemical Dictionary, Fourth Edition, Julius Grant, 1972, page 203
	W	Merriam-Webster Online Dictionary, copyright 2007-2008
	X	Crystallization, Wikipedia, http://en.wikipedia.org/wiki/Crystallization

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Riley, J. Chem. Soc. Chem. Commun., 1983, 1530-1532
	V	
	W	
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